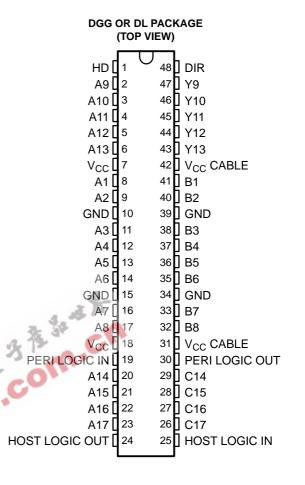


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FEATURES

Auto-Power-Up Feature Prevents Printer Errors When Printer Is Turned On, But No Valid Signal Is at A9–A13 Pins 1.4-k() Pullup Resistors Integrated on All

- 1.4-kΩ Pullup Resistors Integrated on All Open-Drain Outputs Eliminate the Need for Discrete Resistors
- Designed for IEEE Std 1284-I (Level-1 Type) and IEEE Std 1284-II (Level-2 Type) Electrical Specifications
- Flow-Through Architecture Optimizes PCB Layout
- I_{off} and Power-Up 3-State Support Hot Insertion
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection
 - ±4 kV Human-Body Model
 - ±8 kV IEC 61000-4-2, Contact Discharge (Connector Pins)
 - ±15 kV IEC 61000-4-2, Air-Gap Discharge (Connector Pins)
 - ±15 kV Human-Body Model (Connector Pins)



DESCRIPTION/ORDERING INFORMATION

The SN74LVCE161284 is designed for 3-V to 3.6-V V_{CC} operation. This device provides asynchronous two-way communication between data buses. The control-function implementation minimizes external timing requirements.

This device has eight bidirectional bits; data can flow in the A-to-B direction when the direction-control input (DIR) is high and in the B-to-A direction when DIR is low. This device also has five drivers that drive the cable side and four receivers. The SN74LVCE161284 has one receiver dedicated to the HOST LOGIC line and a driver to drive the PERI LOGIC line.

ORDERING INFORMATION

T _A	PACKAGE ⁽¹⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	SSOP – DL	Tube	SN74LVCE161284DL	1.1/05464004	
0°C to 70°C	330P – DL	Tape and reel	SN74LVCE161284DLR	LVCE161284	
	TSSOP - DGG	Tape and reel	SN74LVCE161284DGGR	LVCE161284	

 Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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DESCRIPTION/ORDERING INFORMATION (CONTINUED)

The output drive mode is determined by the high-drive (HD) control pin. When HD is high, the outputs are in a totem-pole configuration, and in an open-drain configuration when HD is low. This meets the drive requirements as specified in the IEEE Std 1284-I (level-1 type) and IEEE Std 1284-II (level-2 type) parallel peripheral-interface specifications. Except for HOST LOGIC IN and peripheral logic out (PERI LOGIC OUT), all cable-side pins have a 1.4-k Ω integrated pullup resistor. The pullup resistor is switched off if the associated output driver is in the low state or if the output voltage is above V_{CC} CABLE. If V_{CC} CABLE is off, PERI LOGIC OUT is set to low.

The device has two supply voltages. V_{CC} is designed for 3-V to 3.6-V operation. V_{CC} CABLE supplies the inputs and output buffers of the cable side only and is designed for 3-V to 3.6-V and for 4.7-V to 5.5-V operation. Even when V_{CC} CABLE is 3 V to 3.6 V, the cable-side I/O pins are 5-V tolerant.

The Y outputs (Y9–Y13) stay in the high state after power on until an associated input (A9–A13) goes high. When an associated input goes high, all Y outputs are activated, and noninverting signals of the associated inputs are driven through Y outputs. This special feature prevents printer-system errors caused by deasserting the BUSY signal in the cable at power on.

FUNCTION TABLE

INP	UTS	CUITDUIT	MODE					
DIR	HD	OUTPUT	MODE					
		Open drain	A9–A13 to Y9–Y13 and PERI LOGIC IN to PERI LOGIC OUT					
L	L	Totem pole	B1-B8 to A1-A8 and C14-C17 to A14-A17					
L	Н	Totem pole	B1-B8 to A1-A8, A9-A13 to Y9-Y13, PERI LOGIC IN to PERI LOGIC OUT, and C14-C17 to A14-A17					
Н		Open drain	A1-A8 to B1-B8, A9-A13 to Y9-Y13, and PERI LOGIC IN to PERI LOGIC OUT					
	L	Totem pole	C14-C17 to A14-A17					
Н	Н	Totem pole	A1-A8 to B1-B8, A9-A13 to Y9-Y13, C14-C17 to A14-A17, and PERI LOGIC IN to PERI LOGIC OUT					



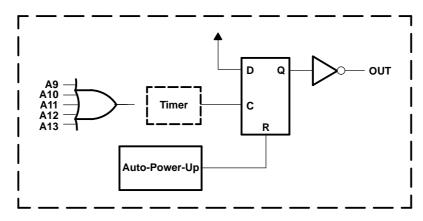
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LOGIC DIAGRAM V_{CC} CABLE 42 See Note A 48 DIR -See Note A HD ____ See Note B B1-B8 A1-A8 A9-A13 Y9-Y13 See Note C PERI LOGIC IN PERI LOGIC OUT C14-C17 A14-A17 HOST LOGIC OUT -- HOST LOGIC IN

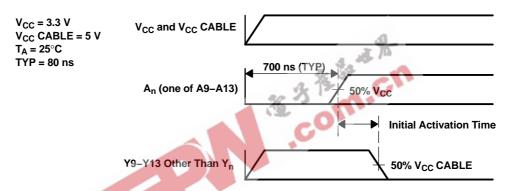
NOTES: A. The PMOS transistors prevent backdriving current from the signal pins to V_{CC} CABLE when V_{CC} CABLE is open or at GND. The PMOS transistor is turned off when the associated driver is in the low state.

- B. The PMOS transistor prevents backdriving current from the signal pins to V_{CC} CABLE when V_{CC} CABLE is open or at GND.
- C. Active input detection circuit forces Y9-Y13 to the high state after power-on, until one of the A9-A13 goes high (see Figure 1).





Active Input Detection Circuit



NOTE A: One of A9-A13 is switched as shown above, and the other four inputs are forced to low state.

Figure 1. Error-Free Circuit Timing



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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT	
V _{CC} CABLE	Supply voltage range		-0.5	7	V	
V _{CC}	Supply voltage range	erange				
V _I ,	Leaved and audicide reflexive management	Cable side ⁽²⁾⁽³⁾	-2	7	V	
Vo	Input and output voltage range	Peripheral side ⁽²⁾	-0.5	V _{CC} + 0.5	V	
I _{IK}	Input clamp current	V _I < 0		-20	mA	
I _{OK}	Output clamp current	V _O < 0		-50	mA	
	Continuous sustant sussess	Except PERI LOGIC OUT		±50	mA	
Io	Continuous output current	PERI LOGIC OUT		±100	mA	
	Continuous current through each V _{CC} or GND			±200	mA	
I _{SK}	Output high sink current	V _O = 5.5 V and V _{CC} CABLE = 3 V		65	mA	
0	Dealer at the second instruction of (1)	DGG package		70	°C/W	
θ_{JA}	Package thermal impedance ⁽⁴⁾	DL package		-0/00		
T _{stg}	Storage temperature range		-65	150	°C	

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

The ac input-voltage pulse duration is limited to 40 ns if the amplitude is greater than -0.5 V. The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions (1)

	N.		MIN	MAX	UNIT	
V _{CC} CABLE	Supply voltage for the cable side, V _{CC} CABLE ≥ 1	Vcc	3	5.5	V	
V _{CC}	Supply voltage		3	3.6	V	
		A, B, DIR, and HD	2			
M	I Pak Javel Secretaria	C14-C17	2.3		V	
V_{IH}	High-level input voltage	HOST LOGIC IN	2.6		V	
		PERI LOGIC IN	2			
		A, B, DIR, and HD		0.8		
V	Low level input valtege	C14-C17		8.0	V	
V_{IL}	Low-level input voltage	HOST LOGIC IN		1.6		
		PERI LOGIC IN		8.0		
M	lanut valtaga	Peripheral side	0	V _{CC}	V	
V _I	Input voltage	Cable side	0	5.5	V	
Vo	Open-drain output voltage	HD low	0	5.5	V	
		HD high, B and Y outputs		-14		
I _{OH}	High-level output current	A outputs and HOST LOGIC OUT		-4	mA	
		PERI LOGIC OUT		-0.5		
		B and Y outputs		14		
I_{OL}	Low-level output current	A outputs and HOST LOGIC OUT	4		mA	
			84			
T _A	Operating free-air temperature		0	70	°C	

All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	V _{cc}	V _{CC} CABLE	MIN TYP(1)	MAX	UNIT	
ΔV_{t}	All inputs except the C inputs and HOST LOGIC IN				0.4			
Hysteresis (V _{T+} – V _{T-})	HOST LOGIC IN		3.3 V	5 V	0.2		V	
(v _{T+} - v _{T-})	C inputs				0.8	0.8		
	HELL B. IV.		3 V	3 V	2.23			
	HD high, B and Y outputs	$I_{OH} = -14 \text{ mA}$	3.3 V	4.7 V	2.4			
\ <i>/</i>	HD high, A outputs, and	$I_{OH} = -4 \text{ mA}$	2.1/	2.1/	2.4		V	
V_{OH}	HOST LOGIC OUT	$I_{OH} = -50 \mu A$	3 V	3 V	2.8		V	
	DEDIT COLO CLIT		3.15 V	3.15 V	3.1			
	PERI LOGIC OUT	$I_{OH} = -0.5 \text{ mA}$	3.3 V	4.7 V	4.5			
	B and Y outputs	I _{OL} = 14 mA				0.77		
	A outputs and	$I_{OL} = 50 \mu\text{A}$	0.1/	0.1/		0.2		
V_{OL}	HOST LOGIC OUT	I _{OL} = 4 mA	3 V	3 V		0 4	V	
	PERI LOGIC OUT	I _{OL} = 84 mA		3 15		0.9		
		M M	- 40	100		50	μΑ	
I _I	C inputs	V _I = GND (pullup resistors)	3.6 V	3.6 V		-3.5	mA	
	All inputs except B or C inputs	$V_I = V_{CC}$ or GND	OU	5.5 V		±1	μΑ	
	A1–A8	$V_O = V_{CC}$ or GND	C	5.5.7		±20	^	
		$V_O = V_{CC}$ CABLE		5.5 V		50	μΑ	
l _{OZ}	B outputs	V _O = GND (pullup resistors)	3.6 V	3.6 V	-3.5 -3.5		mA	
	Open-drain Y outputs	V _O = GND (pullup resistors)		3.0 V			IIIA	
I _{OZPU}	B and Y outputs	V _O = 5.5 V	0 to 1.5 V ⁽²⁾	0 to 1.5 V ⁽²⁾		350	μΑ	
'OZPU	D and 1 outputs	$V_O = GND$	0 10 1.0 0	0 10 1.0 0		- 5	mA	
l	B and Y outputs	$V_0 = 5.5 \text{ V}$	0 to 1.5 V ⁽²⁾	0 to 1.5 V ⁽²⁾		350	μΑ	
I _{OZPD}	B and 1 outputs	$V_O = GND$	0 10 1.5 V	0 10 1.5 0		-5	mA	
I _{off}	Power-down input leakage, except A1–A8 or B1–B8 inputs	V_1 or $V_0 = 0$ to 3.6 V	0	0		100	μΑ	
оп	Power-down output leakage, B1–B8 and Y9–Y13 outputs	V_I or $V_O = 0$ to 5.5 V	Ů	Ü	100		μ.	
		$V_I = GND$		3.6 V		45		
I_{CC}		(12 × pullup)	3.6 V	5.5 V		70	mA	
	·	$V_I = V_{CC},$ $I_O = 0$		3.6 V		8.0		
Z _O	B1-B8, Y9-Y13	$I_{OH} = -35 \text{ mA}$	3.3 V	3.3 V	36		Ω	
R pullup	B1-B8, Y9-Y13, C14-C17	V _O = 0 V (in high-impedance state)	3.3 V	3.3 V	1.15	1.65	$k\Omega$	
C _i	A9–A13, DIR, HD, PERI LOGIC IN	$V_I = V_{CC}$ or GND	3.3 V	5 V	6.5		pF	
•	HOST LOGIC IN	55			4			
0	A1–A8	V V an CND	221/	5 \/	8	8		
C_{io}	B1-B8	$V_O = V_{CC}$ or GND	3.3 V	5 V	13	pF		

 $[\]begin{array}{ll} \hbox{(1)} & \hbox{Typical values are measured at $T_A=25^\circ$C.} \\ \hbox{(2)} & \hbox{Connect the V_{CC} pin to the V_{CC} CABLE pin.} \\ \end{array}$



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Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 2 and Figure 3)

PAR	AMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾	ИΑХ	UNIT	
t _{PLH}	Totem pole	A1–A8	B1–B8	2		30	ns	
t _{PHL}	Totem pole	A 1–A6	D I-D0	2		30	115	
t _{PLH}	Totem pole	A9–A13	Y9–Y13	2		30	ns	
t _{PHL}	Totem pole	A9-A13	19–113	2		30	115	
t _{PLH}	Totem pole	B1–B8	A1–A8	2		12	ns	
t _{PHL}	Totem pole	DI-Do	AT-Ao	2		12	115	
t _{PLH}	Totem pole	C14-C17	A14–A17	2		14	no	
t _{PHL}	Totem pole	C14–C17	A14–A17	2		14	ns	
t _{PLH}	Totom nole	PERI LOGIC IN	PERI LOGIC OUT	2		16	20	
t _{PHL}	Totem pole	PERI LOGIC IN	PERI LOGIC OUT	2		16	ns	
t _{PLH}	Totom nole	HOST LOGIC IN	HOST LOGIC OUT	1		18	20	
t _{PHL}	Totem pole	HOST LOGIC IN	HOST LOGIC OUT	1		18	ns	
t _{slew}	Totem pole	B1-B8 and Y9	9–Y13 outputs	0.05		0.4	V/ns	
t _{PZH}		HD	B1–B8, Y9–Y13, and	2		30	no	
t _{PHZ}		ПО	PERI LOGIC OUT	2		25	ns	
t _{en} -t _{dis}		DIR	A1-A8	2		25	ns	
t _{PHZ}		DID	P4 P0	2		25		
t _{PLZ}		DIR	B1–B8	2		25	ns	
t _r , t _f	Open drain	A1–A13	B1-B8 or Y9-Y13	1		120	ns	
t _{sk(o)} (2)		A1–A8 or B1–B8	B1-B8 or A1-A8		3	10	ns	

Table 1. ESD Protection

PIN	TEST CONDITIONS	TYP	UNIT
B1–B8, Y9–Y13, PERI LOGIC OUT, C14–C17, HOST LOGIC IN	НВМ	±15	
	Contact discharge, IEC 61000-4-2	±8	kV
	Air-gap discharge, IEC 61000-4-2	±15	
DIR, HD, A1–A8, A9–A13, PERI LOGIC IN, A14–A17, HOST LOGIC OUT	нвм	±4	kV

Operating Characteristics

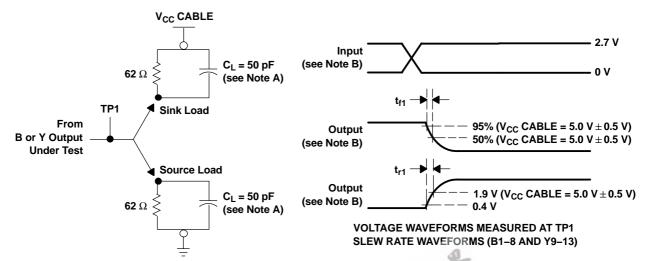
 V_{CC} and V_{CC} CABLE = 3.3 V, C_L = 0, f = 10 MHz, T_A = 25°C

	PARAMETER	FROM (INPUT)	TO (OUTPUT)	TYP	UNIT
		Α	В	15	
		A	Y	6	-F
0	Davis discipation consistence	PERI LOGIC IN	PERI LOGIC OUT	10	
C _{pd}	Power dissipation capacitance	В	А	33	pF
		С	А	29	
		HOST LOGIC IN	HOST LOGIC OUT	29	

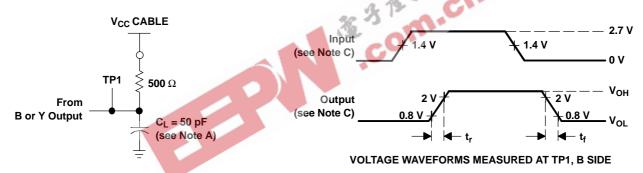
⁽¹⁾ Typical values are measured at V_{CC} = 3.3 V, V_{CC} CABLE = 5 V, and T_A = 25°C. (2) Skew is measured at 1/2 (V_{OH} + V_{OL}) for signals switching in the same direction.



PARAMETER MEASUREMENT INFORMATION



SLEW RATE A-TO-B OR A-TO-Y LOAD (TOTEM POLE) OR PERI LOGIC IN TO PERI LOGIC OUT



A-TO-B LOAD OR A-TO-Y LOAD (OPEN DRAIN) OR PERI LOGIC IN TO PERI LOGIC OUT

NOTES: A. C_L includes probe and jig capacitance.

B. When V_{CC} CABLE is 3.3 V \pm 0.3 V, slew rate is measured between 0.4 V and 0.9 V for the rising edge and between 2.4 V and 1.9 V for the falling edge. When V_{CC} CABLE is 5 V \pm 0.5 V, slew rate is measured between 0.4 V and 1.9 V for the rising edge and between 95% V_{CC} CABLE and 50% V_{CC} CABLE for the falling edge.

$$\mathrm{t_{slew}}\,\mathrm{fall}\,=\,\mathrm{V_{CC}}\!\!\left(\frac{95\%-50\%}{\mathrm{t_{f1}}}\right) \qquad \mathrm{t_{slew}}\,\mathrm{rise}\,=\,\left(\frac{1.9\;\mathrm{V}-0.4\;\mathrm{V}}{\mathrm{t_{r1}}}\right)$$

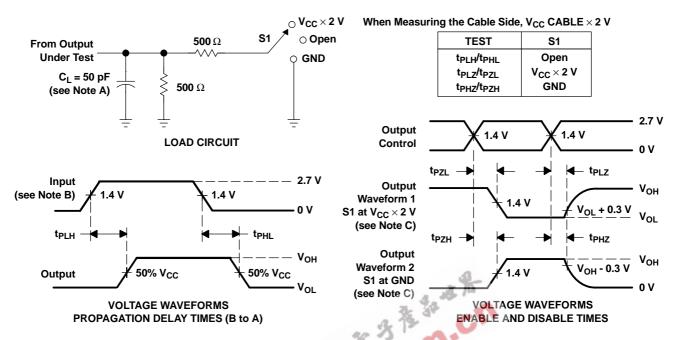
- C. Input rise (t_r) and fall (t_f) times are 3 ns. Rise and fall times (open drain) are <120 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en}.
- G. t_{PLH} and t_{PHL} are the same as t_{pd}.

Figure 2. Load Circuits and Voltage Waveforms

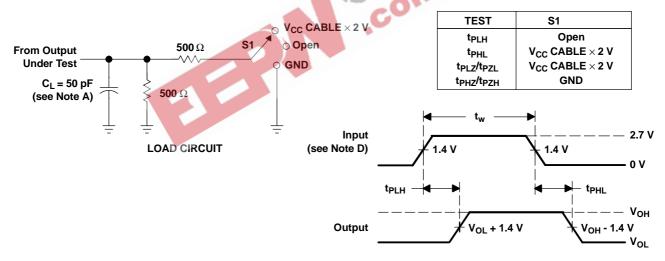


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PARAMETER MEASUREMENT INFORMATION



HOST LOGIC IN TO HOST LOGIC OUT OR B-TO-A LOAD (TOTEM POLE)



VOLTAGE WAVEFORMS MEASURED AT TP1 PROPAGATION DELAY TIMES (A to B)

A-TO-B LOAD OR A-TO-Y LOAD (TOTEM POLE) OR PERI LOGIC IN TO PERI LOGIC OUT

NOTES: A. C_L includes probe and jig capacitance.

- B. Input rise and fall times are 3 ns.
- C. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- D. Input rise and fall times are 3 ns. Pulse duration is 150 ns < $t_{\rm W}$ < 10 μs .
- E. The outputs are measured one at a time, with one transition per measurement.
- F. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
- G. t_{PZL} and t_{PZH} are the same as t_{en} .
- H. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 3. Load Circuits and Voltage Waveforms



PACKAGE OPTION ADDENDUM

27-Sep-2007

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins I	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74LVCE161284DGGRE4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCE161284DGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCE161284DLG4	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCE161284DLRG4	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCE161284VRE4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCE161284VRG4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCE161284DGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCE161284DL	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCE161284DLR	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCE161284VR	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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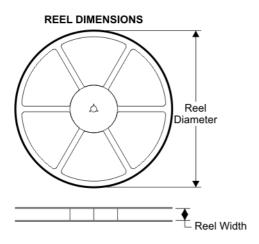
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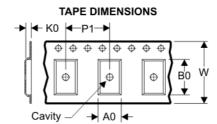


PACKAGE MATERIALS INFORMATION

4-Oct-2007

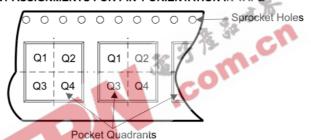
TAPE AND REEL BOX INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPES

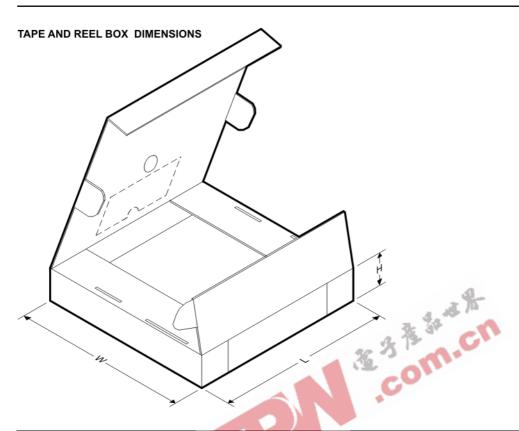


Device	Package	Pins		Reel Diameter (mm)	Reel Width (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVCE161284DGGR	DGG	48	SITE 41	330	24	8.6	15.8	1.8	12	24	Q1
SN74LVCE161284DLR	DL	48	SITE 41	330	32	11.35	16.2	3.1	16	32	Q1
SN74LVCE161284VR	DGV	48	SITE 41	330	24	6.8	10.1	1.6	12	24	Q1





4-Oct-2007

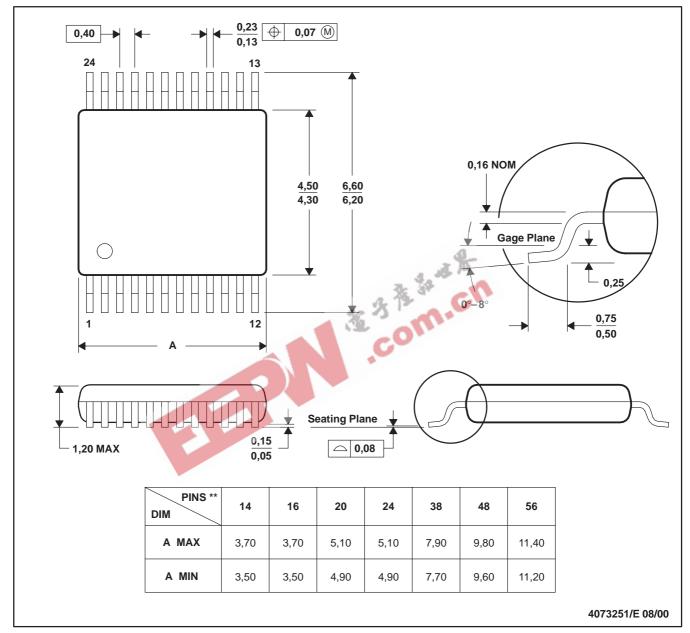


Device	Package	Pins	Site	Length (mm)	Width (mm)	Height (mm)
SN74LVCE161284DGGR	DGG	48	SITE 41	346.0	346.0	41.0
SN74LVCE161284DLR	DL	48	SITE 41	346.0	346.0	49.0
SN74LVCE161284VR	DGV	48	SITE 41	346.0	346.0	41.0

DGV (R-PDSO-G**)

24 PINS SHOWN

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

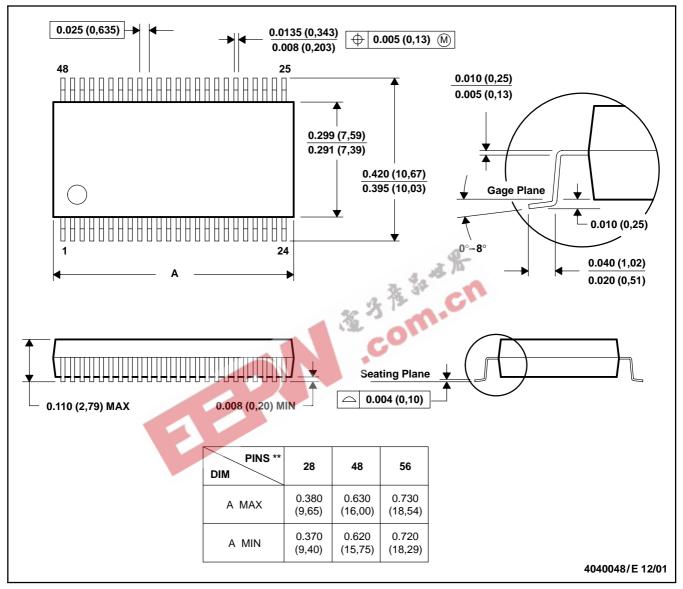
D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194



DL (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



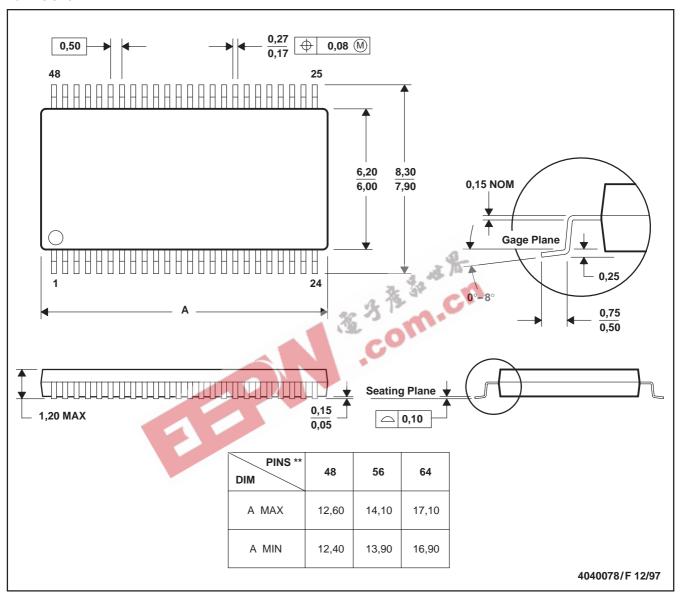
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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